	Application No.	Applicant(s)
Notice of Allowability	09/807,131	HUTTUNEN, MIKKO
	Examiner	Art Unit
	Ted M. Wang	2634
The MAILING DATE of this communication appear All claims being allowable, PROSECUTION ON THE MERITS IS (herewith (or previously mailed), a Notice of Allowance (PTOL-85) of NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIC of the Office or upon petition by the applicant. See 37 CFR 1.313	OR REMAINS) CLOSED in other appropriate commemorates. This application is	n this application. If not included unication will be mailed in due course. THIS
1. X This communication is responsive to 10/26/2005.		
2. X The allowed claim(s) is/are <u>1,2,5-7,10-12 and 15</u> .		
 3. Acknowledgment is made of a claim for foreign priority under a) All b) Some* c) None of the: 1. Certified copies of the priority documents have 2. Certified copies of the priority documents have 3. Copies of the certified copies of the priority documents 	been received. been received in Applicati	on No
International Bureau (PCT Rule 17.2(a)).		
* Certified copies not received:		
Applicant has THREE MONTHS FROM THE "MAILING DATE" of noted below. Failure to timely comply will result in ABANDONME THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		e a reply complying with the requirements
 A SUBSTITUTE OATH OR DECLARATION must be submit INFORMAL PATENT APPLICATION (PTO-152) which gives 		
5. CORRECTED DRAWINGS (as "replacement sheets") must	be submitted.	
(a) 🔲 including changes required by the Notice of Draftsperso	on's Patent Drawing Revie	w (PTO-948) attached
1) 🗌 hereto or 2) 🔲 to Paper No./Mail Date		• ·
(b) ☐ including changes required by the attached Examiner's Paper No./Mail Date		
Identifying indicia such as the application number (see 37 CFR 1.8 each sheet. Replacement sheet(s) should be labeled as such in th		
 DEPOSIT OF and/or INFORMATION about the depos attached Examiner's comment regarding REQUIREMENT F 		
Attachment(s) 1. X Notice of References Cited (PTO-892)	5. ☐ Notice of I	nformal Patent Application (PTO-152)
2. Notice of Draftperson's Patent Drawing Review (PTO-948)	6. Interview S	Summary (PTO-413),
3. Information Disclosure Statements (PTO-1449 or PTO/SB/08	Paper No. 3), 7. ☐ Examiner's	/Mail Date : Amendment/Comment
Paper No./Mail Date 4. Examiner's Comment Regarding Requirement for Deposit of Biological Material	8. 🛛 Examiner's	Statement of Reasons for Allowance
	9. 🔲 Other	<u>_</u> .

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DETAILED ACTION

Examiner's Statement

1. Applicants' amendments and arguments, filed on 10/26/2005, with respect to Claims 1-2, 5-7, 10-12, and 15 have been fully considered. The 35U.S.C. 103(a) rejection has been overcome by rewritten those objected depend claims in independent form including all of the limitations of the base claim and any intervening claims. None of the previously cited reference teaches the amended independent Claims 1, 6, and 11.

Allowable Subject Matter

- 2. Claims 1-2, 5-7, 10-12, and 15 are allowed.
- 3. The following is an examiner's statement of reasons for allowance.
 - The prior art fails to teach a method/receiver of Claims 1, 6, and 11 that specifically comprises the following:
 - -- The instant application is deemed to be directed to a non-obvious improvement over the admitted prior art of the instant application and the invention patented in Pat. No. US 6,463,107, US 6,058,138, US 5,533,066, and US 5,199,047, US 5,140,617. The improvement comprises that

With regard claims 1 and 6, "calculating an absolute value of an average of the determined cross-correlation values; selecting the first detector for the detection of the signal to be received if the absolute value

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of the average of the cross-correlation values exceeds a preset limit value; and selecting the second detector if the absolute value of the average of the cross-correlation values is below a preset limit value as recited", and

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With claim 11, "a second calculator configured to calculate an absolute value of an average of the determined cross-correlation values; wherein the selector is configured to select the first detector for the detection of the signal to be received if the absolute value of the average of the cross-correlation values exceeds a preset limit value and configured to select the second detector if the absolute value of the average of the cross-correlation values is below the preset limit value" as recited.

4. Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Conclusion

5. Reference(s) US 6,058,138 is cited because they are put pertinent to the demodulating and detecting with the comparison results of average cross-correlation values and threshold. However, none of references teach detailed connection as recited in claim.

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6. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Ted M. Wang whose telephone number is (571) 272-

3053. The examiner can normally be reached on M-F, 7:30 AM to 5:00 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's

supervisor, Stephen Chin can be reached on (571) 272-3056. The fax phone number

for the organization where this application or proceeding is assigned is (703) 872-9306.

Information regarding the status of an application may be obtained from the

Patent Application Information Retrieval (PAIR) system. Status information for

published applications may be obtained from either Private PAIR or Public PAIR.

Status information for unpublished applications is available through Private PAIR only.

For more information about the PAIR system, see http://pair-direct.uspto.gov. Should

you have questions on access to the Private PAIR system, contact the Electronic

Business Center (EBC) at (866) 217-9197 (toll-free).

Ted M Wang

Examiner

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Ted M. Wang

STEPHEN CHIN

SUPERVISORY PATENT EXAMINE

TECHNOLOGY CENTER 2600